



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Applicant(s): Milton Feng, Nick Holonyak, Jr. and Walid Hafez

Serial No. : 10/646,457

Group: 2811

Filed

: August 22, 2003

For

: LIGHT EMITTING DEVICE AND METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

Name of applicant, assigned or registered rep.

Applicant submits herewith a Form PTO-1449, and copies of the documents listed thereon.

To the best of Applicant's knowledge, this Information Disclosure Statement is being filed before the first Office Action on the merits in the present application, so no fee is due under Rule 97.

The listed documents are brought to the Examiner's attention because they are known to Applicant and/or Applicant's attorney and may be considered by the Examiner to be material to the examination of this application. This submission should not be

construed as a representation that a search has been made or that no better art exists.

No inference should be made that the documents constitute prior art or are in fact material merely because they are referenced in this submission.

Delray Beach, Florida Tel. (561) 498-4706 Fax. (561) 498-4027 March 1, 2004

(F-5)

Respectfully submitted,

Martin Novack

Attorney for Applicant(s)

Form PTO-1449 U.S. Department of Commerce Patent and Trademark Office

INFORMATION DISCLOSURE STATEMENT BY APPLICANT MAR 0 4 2004

(Use several sheets if necessary)

ATTY DOCKET NO. UI-TF-03050

SERIAL NO. 10/646,457

APPLICANT:

EXAMINER

M.Feng, N. Holonyak, & W. Hafez

FILING DATE: August 22, 2003 GROUP 2811

PATENT DOCUMENTS

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Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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			U.S. PATENT DOCUMENTS					
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